

Notice of References Cited

Application/Control No.

10/521,943

Applicant(s)/Patent Under
Reexamination
SUEHIRO ET AL.

Examiner

David J. Makiya

Art Unit

2885

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0245201 A1	11-2006	Wada et al.	362/545
*	B	US-7,246,921 B2	07-2007	Jacobson et al.	362/294
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NON-PATENT DOCUMENTS

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